

**Search Notes**

Application/Control No.

10/682,224

Examiner

Anthony Weier

Applicant(s)/Patent under  
Reexamination

KIKUCHI ET AL.

Art Unit

1761

**SEARCHED**

Class	Subclass	Date	Examiner
426	634, 518, 486, 507	6/7/2005	AW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	6/7/2005	AW